

Single N-channel MOSFET

ELM4N6056FDA-N

<http://www.elm-tech.com>

■General description

ELM4N6056FDA-N uses advanced trench technology to provide excellent $R_{ds(on)}$, low gate charge and low gate threshold voltage.

■Features

- $V_{ds}=60V$
- $I_d=58A$ ($V_{gs}=10V$)
- $R_{ds(on)} = 8.5m\Omega$ ($V_{gs}=10V$)
- $R_{ds(on)} = 12.5m\Omega$ ($V_{gs}=4.5V$)

■Maximum absolute ratings

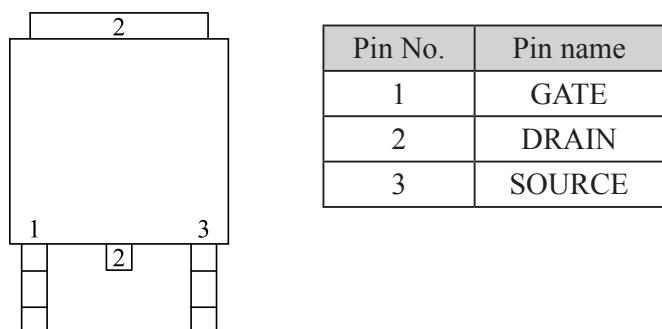
Parameter	Symbol	Limit	Unit	Note
Drain-source voltage	V_{ds}	60	V	
Gate-source voltage	V_{gs}	± 20	V	
Continuous drain current ($V_{gs}=10V$)	I_d	58.0	A	1, 6
		36.6		
Pulsed drain current	I_{dm}	125	A	2
Single pulse avalanche energy	E_{as}	26.5	mJ	3
Avalanche current	I_{as}	23	A	
Power dissipation	P_d	52	W	4
Storage temperature range	T_{stg}	-55 to 150	°C	
Operating junction temperature range	T_j	-55 to 150	°C	

■Thermal characteristics

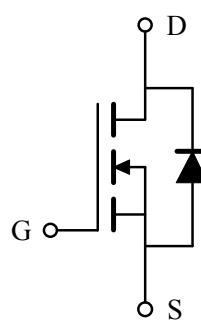
Parameter	Symbol	Typ.	Max.	Unit	Note
Thermal resistance junction-ambient (Steady state)	$R_{\theta ja}$	-	60.0	°C/W	1
Thermal resistance junction-case ambient	$R_{\theta jc}$	-	2.4	°C/W	1

■Pin configuration

TO-252(TOP VIEW)



■Circuit



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■Electrical characteristics

T_j=25°C. Unless otherwise noted.

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit	Note
STATIC PARAMETERS							
Drain-source breakdown voltage	BVdss	V _{gs} =0V, I _d =250μA	60	-	-	V	
Drain-source leakage current	Idss	V _{ds} =48V, V _{gs} =0V	-	-	1	μA	
		V _{ds} =48V, V _{gs} =0V, T _j =55°C	-	-	5		
Gate-body leakage current	Igss	V _{gs} =±20V, V _{ds} =0V	-	-	±100	nA	
Gate threshold voltage	V _{gs(th)}	V _{ds} =V _{gs} , I _d =250μA	1.2	-	2.3	V	
Static drain-source on-resistance	R _{ds(on)}	V _{gs} =10V, I _d =20A	-	7.5	8.5	mΩ	2
		V _{gs} =4.5V, I _d =15A	-	11.0	12.5		
Diode forward voltage	V _{sd}	V _{gs} =0V, I _s =1A	-	-	1.2	V	2
Max. body-diode continuous current	I _s	V _{gs} =V _{ds} =0V, Force current	-	-	30	A	1,5,6
DYNAMIC PARAMETERS							
Input capacitance	C _{iss}	V _{ds} =30V, V _{gs} =0V, f=1MHz	-	1270	-	pF	
Output capacitance	C _{oss}		-	479	-	pF	
Reverse transfer capacitance	C _{rss}		-	40	-	pF	
Gate resistance	R _g	V _{ds} =0V, V _{gs} =0V, f=1MHz	-	1.4	-	Ω	
SWITCHING PARAMETERS							
Total gate charge (10V)	Q _g	V _{ds} =30V, V _{gs} =10V, I _d =15A	-	15.0	-	nC	
Gate-source charge	Q _{gs}		-	3.5	-	nC	
Gate-drain charge	Q _{gd}		-	4.2	-	nC	
Turn-on delay time	t _{d(on)}	V _{ds} =30V, V _{gs} =10V, I _d =15A R _{gen} =3.3Ω	-	7.0	-	ns	
Turn-on rise time	t _r		-	4.5	-	ns	
Turn-off delay time	t _{d(off)}		-	26.0	-	ns	
Turn-off fall time	t _f		-	5.0	-	ns	
Reverse recovery time	t _{rr}	I _f =15A, di/dt=100A/μs	-	22	-	ns	
Reverse recovery charge	Q _{rr}		-	72	-	nC	

NOTE :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
2. Single pulse width limited by junction temperature T_{j(max)}=150°C.
3. The Eas data shows Max. rating . The test condition is V_{dd}=25V, V_{gs}=10V, L=0.1mH, I_{as}=23A
4. The power dissipation is limited by 150°C junction temperature.
5. The data is theoretically the same as I_d and I_{dm}, in real applications, should be limited by total power dissipation.
6. The maximum current rating is package limited.

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■ Typical characteristics

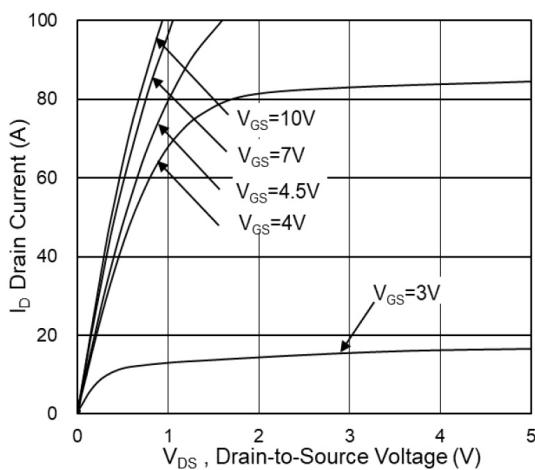


Fig.1 Typical Output Characteristics

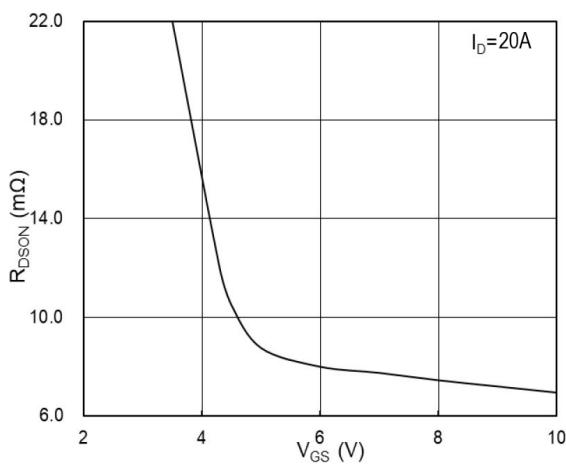


Fig.2 On-Resistance vs G-S Voltage

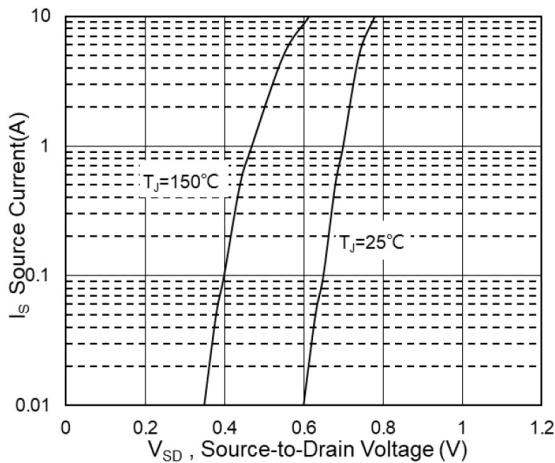


Fig.3 Source Drain Forward Characteristics

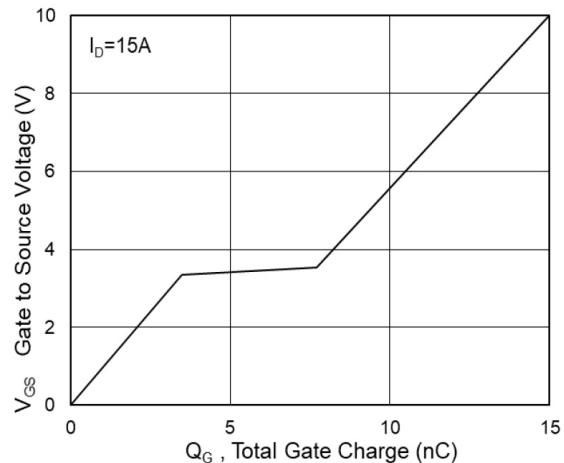


Fig.4 Gate-Charge Characteristics

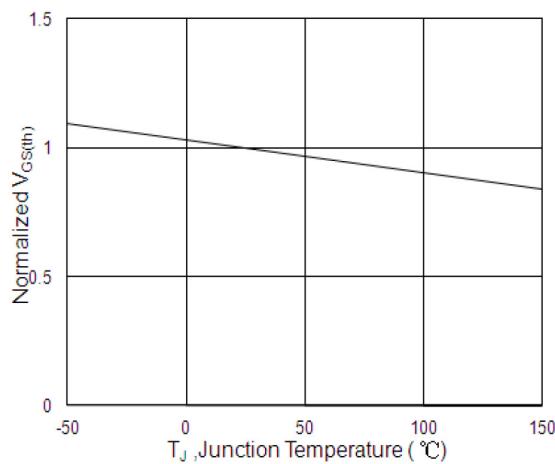


Fig.5 Normalized $V_{GS(th)}$ vs T_J

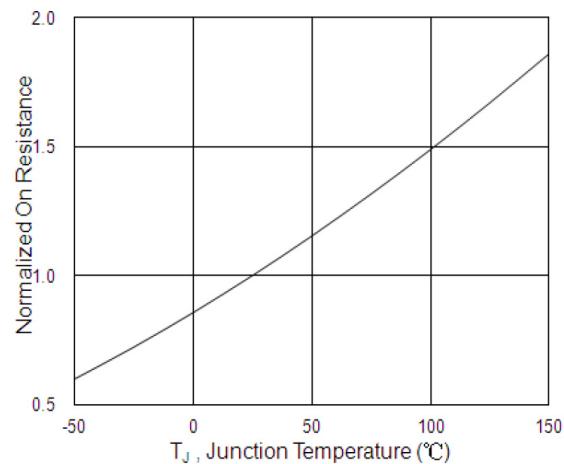


Fig.6 Normalized $R_{DS(on)}$ vs T_J

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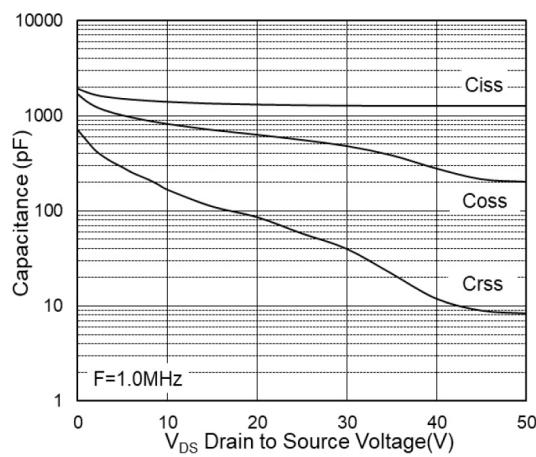


Fig.7 Capacitance

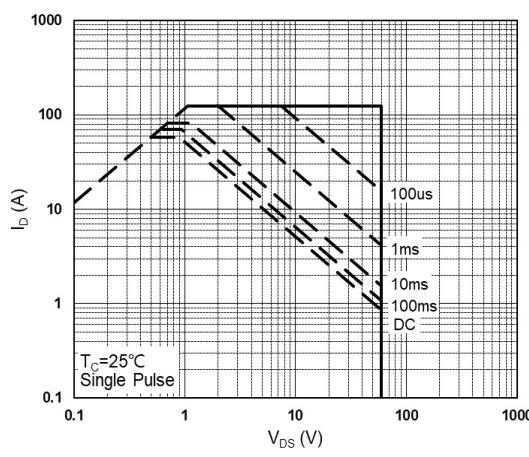


Fig.8 Safe Operating Area

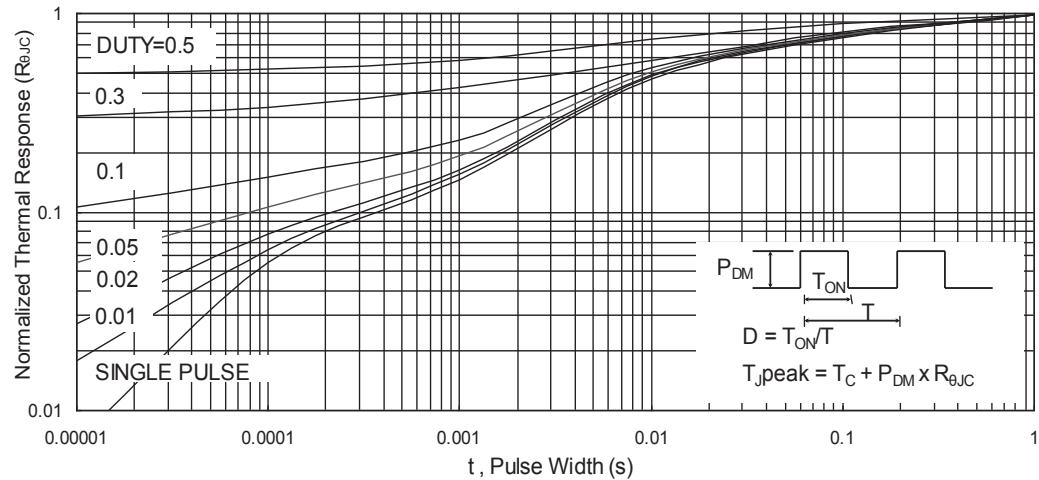


Fig.9 Normalized Maximum Transient Thermal Impedance

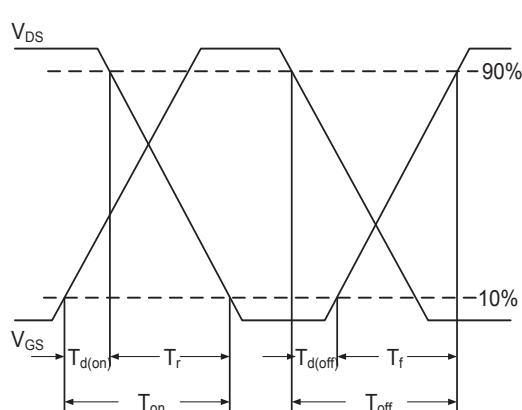


Fig.10 Switching Time Waveform

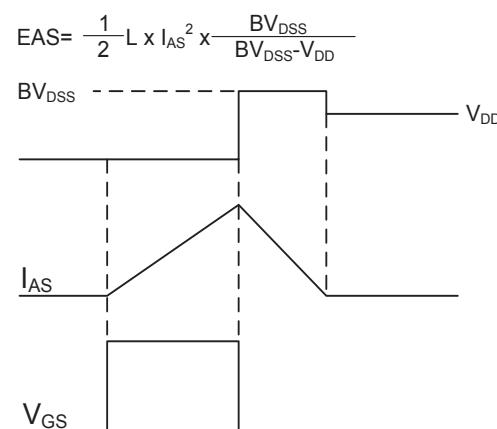


Fig.11 Unclamped Inductive Switching Waveform